



**INFORMATION DISCLOSURE
 CITATION**

APPLN. NO.

10/594,436

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1050-4

APPLICANT

YOSHITAKE et al.

FILING DATE

September 26, 2006

GROUP

1611

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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
	4,432,966	02/1984	Zeitoun et al.			
	4,765,990	08/1988	Sugimoto et al.			
	4,892,742	01/1990	Shah			
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						TRANSLATION	
DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS		YES	NO
2298823	10/1999	CA					
4219390	12/1992	DE				X	
2137862	12/1990	ES				X	
59-044311	03/1984	JP				abstract	
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1010423	06/2000	EP					
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1930030	06/2008	EP					

*Examiner /Kevin Orwig/ Date Considered 11/04/2009

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered.
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